

Collaborative road damage classification and recognition based on edge computing

Dang X, Shang X, Hao Z, Su L.
Electronics (Basel, Switzerland)
2022; 11(20):e3304

ARTICLE IDENTIFIERS

DOI: 10.3390/electronics11203304
PMID: unavailable
PMCID: not available

JOURNAL IDENTIFIERS

LCCN: not available
pISSN: not available
eISSN: 2079-9292
OCLC ID: 830300362
CONS ID: not available
US National Library of Medicine ID: 101630280

This article was identified from a query of the SafetyLit database.